Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/678,061	IMAI ET AL.
Examiner	Art Unit
Chris C. Chu	2815

SEARCHED					
Class	Subclass	Date	Examiner		
257	E21.664, E27.104, 306 & 295	8/11/2006	C.C.		
257	296 & 758	8/11/2006	C.C.		
257	774 & 750	8/11/2006	C.C.		
257	763 & 754	8/11/2006	C.C.		
257	756	8/11/2006	C.C.		
438	238 & 244	8/11/2006	C.C.		
438	003	8/11/2006	C.C.		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
As same	as above	8/11/2006	C.C.	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	8/11/2006	C.C.
Consulted with J. Jackson	8/10/2006	C.C.
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